

IEEE ANTENNAS AND PROPAGATION SOCIETY (AP-S) TECHNICAL COMMITTEE ON ANTENNA MEASUREMENTS (TCAM)

FRIDAY, NOVEMBER 22, 5:00 AM – 1:00 PM UTC-7

Join us for the inaugural one-day workshop brought to you by the IEEE Antennas and Propagation Society's Technical Committee on Antenna Measurements (TCAM). This one-day workshop is open to all IEEE members and guests. There is NO charge to attend, but you must register in advance to ensure adequate seating and meals. Seating is limited and will be filled on a first-come, first-served basis. The technical program features international industry experts, many of whom are members of IEEE AP-S TCAM or Standard Committee, current or past Distinguished Lecturers of the IEEE Antennas and Propagation Society, or IEEE Electromagnetic Compatibility Society. *Remote and in-person registration is available!*

Location: Instituto Nacional de Tecnología Industrial of Argentina (INTI), Av. General Paz Nº 5445, San Martín Buenos Aires, Buenos Aires, Argentina B1650WAB



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Vince Rodriguez

Adjunct Research
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IEEE AP-S TCAM
Member*



**Vikass
Monebhurrn**

Professor
CentraleSupélec
*IEEE AP-S Standard
Committee Chair*

Speakers invited by Joint EMC/AP Chapter Argentina and INTI

- Valentin Trainotti (IEEE Life Fellow)
- Carolina A. Giuffrida
- Julián Galván
- Hugo Command
- Benjamim Galvão

For more information & registration please click [here](#)